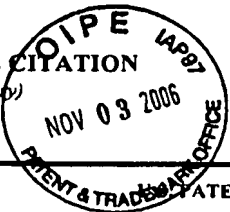


<b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)				Docket Number (Optional) <b>F-13110</b>		Application Number <b>10/827,238</b>	
				Applicant(s) <b>Akitomo OHBA</b>			
				Filing Date <b>April 20, 2004</b>		Group Art Unit <b>2132</b>	

PATENT DOCUMENTS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
/BL/		8-185519	07/16/1996	Japan			ABS	
/BL/		3-142685	06/18/1991	Japan			ABS	
/BL/		2002-259980	09/13/2002	Japan			ABS	
/BL/		2002-83300	03/22/2002	Japan			ABS	

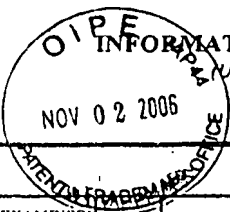
  

OTHER DOCUMENTS		(Including Author, Title, Date, Pertinent Pages, Etc.)
		Japanese Office Action dated February 17, 2006, with partial English language translation

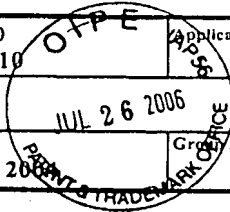
  

EXAMINER <b>/Benjamin Lanier/</b>	DATE CONSIDERED <b>09/12/2007</b>
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

 <p><b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)</p>				Docket Number (Optional) <b>F-13110</b>		Application Number <b>10/827,238</b>		
				Applicant(s) <b>Akitomo OHBA</b>				
				Filing Date <b>April 20, 2004</b>		Group Art Unit <b>2132</b>		
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>								
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<b>FOREIGN PATENT DOCUMENTS</b>								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
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/BL/		4-277872	10/02/1992	Japan			ABS	
		<del>2001-229380</del>	<del>08/24/2001</del>	<del>Japan</del>				
		Cited by applicant in an IDS filed 4/20/04						
<b>OTHER DOCUMENTS</b> (Including Author, Title, Date, Pertinent Pages, Etc.)								
		Japanese Office Action dated August 2, 2006, with partial English language translation						
EXAMINER				DATE CONSIDERED				
/Benjamin Lanier/				09/12/2007				
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<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				Docket Number (Optional) F-13110		Application Number 10/827,238	
				Applicant(s) Akimoto OHBA		Filing Date April 20, 2006	
				Class Art Unit 2132			



U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/BL/		US 4,461,028 A	07/17/84	Okubo et al			

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/BL/		US 2002/154793 A1	10/24/02	Hillhouse et al			

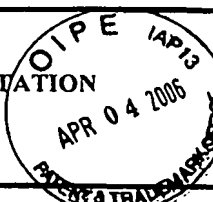
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/BL/		WO 02/095552	11/28/02	WIPO				
/BL/		WO 91/08555 A	06/13/91	WIPO				
/BL/		JP 09-297845	11/18/97	Japan			ABS only	

OTHER DOCUMENTS		(Including Author, Title, Date, Pertinent Pages, Etc.)
		European Search Report dated March 21, 2006.
		Xudong Jiang et al, "Online Fingerprint Template Improvement", IEEE Transactions on Pattern Analysis and Machine Intelligence, IEEE Service Center, Los Alamitos, CA, US, vol. 24, no. 8, August 2002, pages 1121-1126, XP001144040

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<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				ATTY DOCKET NO.		APPLICATION NO.		
				F-13110		10/287,238		
				APPLICANT(S)				
				Akitomo OHBA				
FILING DATE				GROUP ART UNIT				
April 20, 2004				2132				
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
/BL/		Anonymous, "Supervised Adaption for Signature Verification System", IBM Technical Disclosure Bulletin, IBM Corp. New York, US, vol. 21, no. 1, June 1978, pages 424-425, XP002050796.						
EXAMINER				DATE CONSIDERED				
/Benjamin Lanier/				09/12/2007				
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								

<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				Docket Number (Optional) <b>F-13110</b>		Application Number <b>10/827,238</b>	
				Applicant(s) <b>Akitomo Ohba</b>		Group Art Unit <b>2132</b>	
				Filing Date <b>04/20/04</b>			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
U.S. PATENT APPLICATION PUBLICATIONS							
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FOREIGN PATENT DOCUMENTS							
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/BL/	JP11-232459A	08/27/1999	JAPAN			YES	NO
/BL/	CN1299103A	06/13/2001	CHINA			ABS	
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>							
		Chinese Office Action dated December 9, 2005 with English translation					
EXAMINER				DATE CONSIDERED			
/Benjamin Lanier/				09/12/2007			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



